Application/Control No. Applicant(s)/Patent Under Reexamination 09/653,202 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Thoi V Duong 2871 **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 349/153 US-6,259,505 B1 07-2001 Makino, Naoki Α В US-С US-D US-Ε US-F US-US-G US-Н ı US-J US-Κ US-US-US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 P Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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